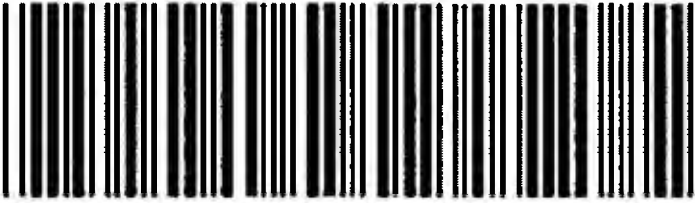


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/604,173	LU ET AL.	
	Examiner	Art Unit	
	XIAO M. WU	2674	

SEARCHED			
Class	Subclass	Date	Examiner
update	search	2/27/2006	X.W.

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR